

# FOD060L, FOD260L, FOD063L LVTTTL/LVCMOS 3.3V High Speed-10 MBit/s Logic Gate Optocouplers

Single Channel: FOD060L, FOD260L  
Dual Channel: FOD063L

## Features

- Compact SO8 package (except FOD260L – 8-pin DIP)
- Very high speed – 10 MBit/s
- Superior CMR — 50 kV/μs at 2,000V peak
- Fan-out of 8 over -40°C to +85°C
- Logic gate output
- Strobable output (single channel devices)
- Wired OR-open collector
- U.L. recognized (File # E90700) (pending)
- UDE approval pending

- Data multiplexing
- Switching power supplies
- Pulse transformer replacement
- Computer-peripheral interface

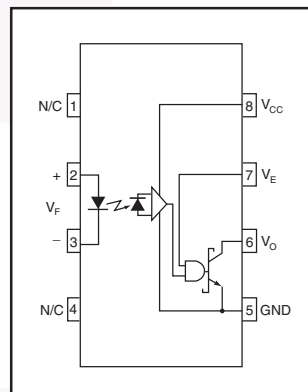
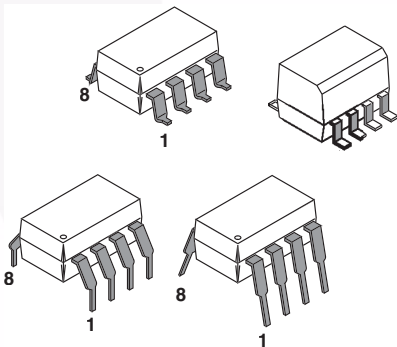
## Applications

- Ground loop elimination
- LSTTL to TTL, LSTTL or 5-volt CMOS
- Line receiver, data transmission

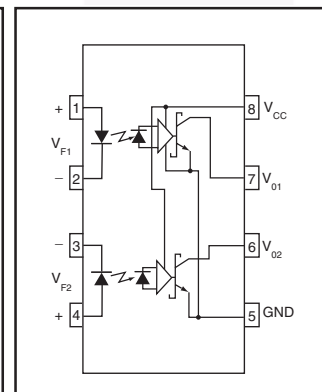
## Description

These optocouplers consist of an AlGaAs LED, optically coupled to a very high speed integrated photo-detector logic gate. Single channel devices include a strobable output. This output features an open collector, thereby permitting wired OR outputs. The output consists of bipolar transistors in a Bi-CMOS process for reduced power consumption. The coupled parameters are guaranteed over the temperature range of -40°C to +85°C. A maximum input signal of 5 mA (3 mA for the FODX6XL versions) will provide a minimum output sink current of 13 mA (fan out of 8). An internal noise shield provides superior common mode rejection of typically 50 kV/μs at 2,000V common mode.

## Package



Single-channel circuit drawing  
(FOD060L, FOD260L)



Dual-channel circuit drawing  
(FOD063L)

## Truth Table (Positive Logic)

Input	Enable	Output
H	H	L
L	H	H
H	L	H
L	L	H
H*	NC*	L*
L*	NC*	H*

\*Dual channel devices or single channel devices with pin 7 not connected.  
A 0.1 μF bypass capacitor must be connected between pins 8 and 5. (See note 1)

**Absolute Maximum Ratings** (No derating required up to 85°C)

Parameter		Symbol	Value	Units
Storage Temperature		$T_{STG}$	-40 to +125	°C
Operating Temperature		$T_{OPR}$	-40 to +85	°C
<b>EMITTER</b>				
DC/Average Forward Input Current (each channel)		$I_F$	50	mA
Enable Input Voltage Not to exceed VCC by more than 500 mV	Single Channel	$V_E$	$V_{CC} + 0.5V$	V
Reverse Input Voltage (each channel)		$V_R$	5.0	V
Power Dissipation	Single Channel	$P_I$	45	mW
	Dual Channel			
<b>DETECTOR</b>				
Supply Voltage		$V_{CC}$ (1 minute max)	7.0	V
Output Current (each channel)		$I_O$	50	mA
Output Voltage (each channel)		$V_O$	7.0	V
Collector Output Power Dissipation	Single Channel	$P_O$	85	mW
	Dual Channel			

**Recommended Operating Conditions**

Parameter	Symbol	Min	Max	Units
Input Current, Low Level	$I_{FL}$	0	250	μA
Input Current, High Level	$I_{FH}$	*6.3	15	mA
Supply Voltage, Output	$V_{CC}$	2.7	3.3	V
Enable Voltage, Low Level (Single Channel)	$V_{EL}$	0	0.8	V
Enable Voltage, High Level (Single Channel)	$V_{EH}$	2.0	$V_{CC}$	V
Operating Temperature	$T_A$	-40	+85	°C
Fan Out (TTL load)	N		8	
Output Pull-up Resistor	$R_L$	330	4K	Ω

\*6.3 mA is a guard banded value which allows for at least 20% CTR degradation. Initial input current threshold value is 5.0 mA or less.

**Electrical Characteristics** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  unless otherwise specified.)**Individual Component Characteristics**

Parameter	Test Conditions	Symbol	Min	Typ**	Max	Unit
<b>EMITTER</b>	( $I_F = 10\text{ mA}$ )	$V_F$			1.8	V
Input Forward Voltage	$T_A = 25^\circ\text{C}$				1.75	
Input Reverse Breakdown Voltage	( $I_R = 10\ \mu\text{A}$ )	$B_{VR}$	5.0			V
Input Capacitance	( $V_F = 0$ , $f = 1\text{ MHz}$ )	$C_{IN}$				pF
Input Diode Temperature Coefficient	( $I_F = 10\text{ mA}$ )	$\Delta V_F/\Delta T_A$				mV/ $^\circ\text{C}$
<b>DETECTOR</b>	( $V_E = 0.5\text{ V}$ )	Single Channel			7	mA
High Level Supply Current	( $I_F = 0\text{ mA}$ , $V_{CC} = 3.3\text{ V}$ )	Dual Channel			10	
Low Level Supply Current	( $V_E = 0.5\text{ V}$ )	Single Channel			10	mA
	( $I_F = 10\text{ mA}$ , $V_{CC} = 3.3\text{ V}$ )	Dual Channel			15	
Low Level Enable Current	( $V_{CC} = 3.3\text{ V}$ , $V_E = 0.5\text{ V}$ )	Single Channel			-1.6	mA
High Level Enable Current	( $V_{CC} = 3.3\text{ V}$ , $V_E = 2.0\text{ V}$ )	Single Channel			-1.6	mA
High Level Enable Voltage	( $V_{CC} = 3.3\text{ V}$ , $I_F = 10\text{ mA}$ )	Single Channel	$V_{EH}$	2.0		V
Low Level Enable Voltage	( $V_{CC} = 3.3\text{ V}$ , $I_F = 10\text{ mA}$ ) (Note 2)	Single Channel	$V_{EL}$		0.8	V

**Switching Characteristics** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 3.3\text{ V}$ ,  $I_F = 7.5\text{ mA}$  unless otherwise specified.)

AC Characteristics	Test Conditions	Device	Symbol	Min	Typ	Max	Unit
Propagation Delay Time to Output High Level	(Note 3) ( $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Fig. 9)	All	$T_{PLH}$			90	ns
Propagation Delay Time to Output Low Level	(Note 4) ( $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Fig. 9)	All	$T_{PHL}$			75	ns
Pulse Width Distortion	( $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Fig. 9)	All	$ T_{PHL} - T_{PLH} $			25	ns
Propagation Delay Skew	( $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Note 5)	All	$t_{PSK}$			40	ns
Output Rise Time (10-90%)	( $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Note 6) (Fig. 9)	All	$t_r$				ns
Output Fall Time (90-10%)	( $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Note 7) (Fig. 12)	All	$t_f$				ns
Enable Propagation Delay Time to Output High Level	( $V_{EH} = 3\text{ V}$ , $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Note 8) (Fig. 10)	Single Channel	All	$t_{ELH}$			ns
Enable Propagation Delay Time to Output Low Level	( $V_{EH} = 3\text{ V}$ , $R_L = 350\ \Omega$ , $C_L = 15\text{ pF}$ ) (Note 9) (Fig. 10)	Single Channel	All	$t_{EHL}$			ns
Common Mode Transient Immunity (at Output High Level)	( $R_L = 350\ \Omega$ ) ( $T_A = 25^\circ\text{C}$ ) ( $I_F = 0\text{ mA}$ , $V_{OH}(\text{Min.}) = 2.0\text{ V}$ ) (Note 10) (Fig. 11)	$ V_{CM}  = 50\text{ V}$	All	$ ICM_H $	25,000	50,000	V/ $\mu\text{s}$
Common Mode Transient Immunity (at Output Low Level)	( $R_L = 350\ \Omega$ ) ( $T_A = 25^\circ\text{C}$ ) ( $I_F = 7.5\text{ mA}$ , $V_{OL}(\text{Max.}) = 0.8\text{ V}$ ) (Note 11) (Fig. 11)	$ V_{CM}  = 50\text{ V}$	All	$ ICM_H $	25,000	50,000	V/ $\mu\text{s}$

**Transfer Characteristics** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  Unless otherwise specified.)

DC Characteristics	Test Conditions	Symbol	Min	Typ**	Max	Unit
High Level Output Current	( $I_F = 250\ \mu\text{A}$ , $V_{CC} = 3.3\ \text{V}$ , $V_O = 3.3\ \text{V}$ )	$I_{OH}$			50	$\mu\text{A}$
	(Note 2) $V_E = 2.0\ \text{V}$   Single Channel					
Low Level Output Voltage	( $V_{CC} = 3.3\ \text{V}$ , $I_F = 5\ \text{mA}$ , $I_{OL} = 13\ \text{mA}$ )	$V_{OL}$			0.6	V
	(Note 2) $V_E = 2.0\ \text{V}$   Single Channel					
Input Threshold Current	( $V_{CC} = 3.3\ \text{V}$ , $V_O = 0.6\ \text{V}$ , $I_{OL} = 13\ \text{mA}$ )	$I_{FT}$			5	mA
	(Note 2) $V_E = 2.0\ \text{V}$   Single Channel					

**Isolation Characteristics** ( $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$  Unless otherwise specified.)

Characteristics	Test Conditions	Device	Symbol	Min	Typ**	Max	Unit
Input-Output Insulation Leakage Current	(Relative humidity = 45%) ( $T_A = 25^\circ\text{C}$ , $t = 5\ \text{s}$ ) ( $V_{I-O} = 3000\ \text{VDC}$ ) (Note 12)		$I_{I-O}$			1.0*	$\mu\text{A}$
Withstand Insulation Test Voltage	$I_{IO} \leq 2\ \mu\text{A}$ , $R_H < 50\%$ , $T_A = 25^\circ\text{C}$ (Note 12) ( $t = 1\ \text{min.}$ )	FOD060L FOD063L	$V_{ISO}$	3750			$V_{RMS}$
		FOD260L		5000			
Resistance (Input to Output)	( $V_{I-O} = 500\ \text{V}$ ) (Note 12)		$R_{I-O}$		$10^{12}$		$\Omega$
Capacitance (Input to Output)	( $f = 1\ \text{MHz}$ ) (Note 12)		$C_{I-O}$		0.6		pF

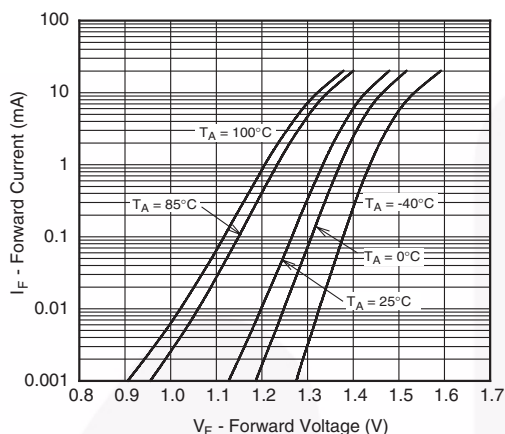
\*\* All typical values are at  $V_{CC} = 3.3\ \text{V}$ ,  $T_A = 25^\circ\text{C}$

**Notes**

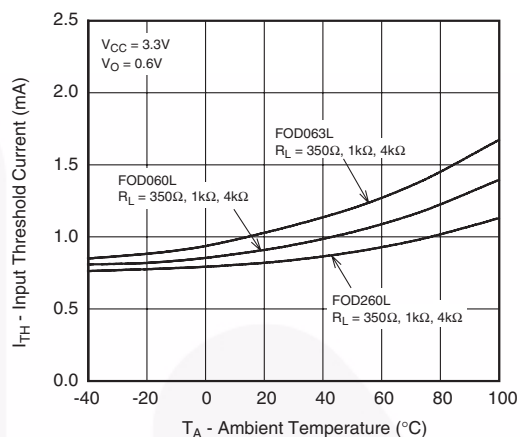
- The  $V_{CC}$  supply to each optoisolator must be bypassed by a  $0.1\ \mu\text{F}$  capacitor or larger. This can be either a ceramic or solid tantalum capacitor with good high frequency characteristic and should be connected as close as possible to the package  $V_{CC}$  and GND pins of each device.
- Enable Input – No pull up resistor required as the device has an internal pull up resistor.
- $t_{PLH}$  – Propagation delay is measured from the 3.75 mA level on the HIGH to LOW transition of the input current pulse to the 1.5V level on the LOW to HIGH transition of the output voltage pulse.
- $t_{PHL}$  – Propagation delay is measured from the 3.75 mA level on the LOW to HIGH transition of the input current pulse to the 1.5V level on the HIGH to LOW transition of the output voltage pulse.
- $t_{PSK}$  is the worst case difference between  $t_{PHL}$  and  $t_{PLH}$  for any devices at the stated test conditions.
- $t_r$  – Rise time is measured from the 90% to the 10% levels on the LOW to HIGH transition of the output pulse.
- $t_f$  – Fall time is measured from the 10% to the 90% levels on the HIGH to LOW transition of the output pulse.
- $t_{ELH}$  – Enable input propagation delay is measured from the 1.5V level on the HIGH to LOW transition of the input voltage pulse to the 1.5V level on the LOW to HIGH transition of the output voltage pulse.
- $t_{EHL}$  – Enable input propagation delay is measured from the 1.5V level on the LOW to HIGH transition of the input voltage pulse to the 1.5V level on the HIGH to LOW transition of the output voltage pulse.
- $CM_H$  – The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the high state (i.e.,  $V_{OUT} > 2.0\ \text{V}$ ). Measured in volts per microsecond ( $\text{V}/\mu\text{s}$ ).
- $CM_L$  – The maximum tolerable rate of fall of the common mode voltage to ensure the output will remain in the low output state (i.e.,  $V_{OUT} < 0.8\ \text{V}$ ). Measured in volts per microsecond ( $\text{V}/\mu\text{s}$ ).
- Device considered a two-terminal device: Pins 1,2,3 and 4 shorted together, and Pins 5,6,7 and 8 shorted together.

## Typical Performance Curves

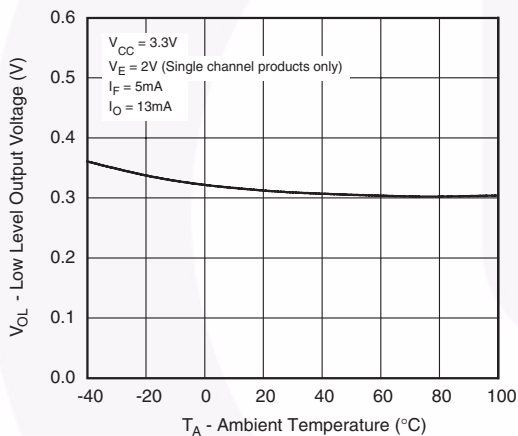
**Fig. 1 Input Forward Current vs. Forward Voltage**



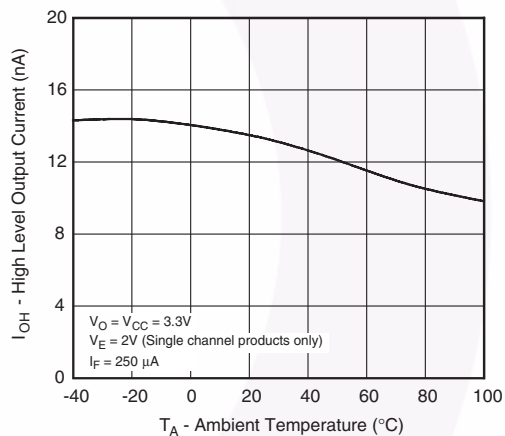
**Fig. 2 Input Threshold Current vs. Ambient Temperature**



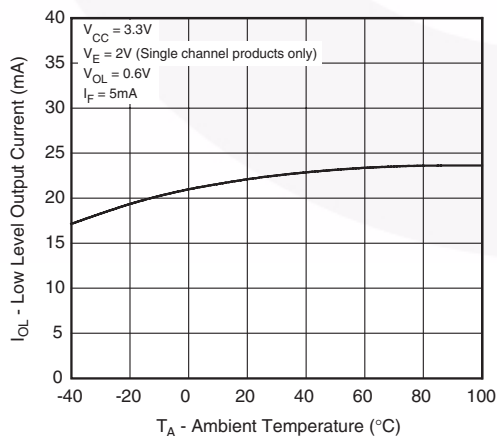
**Fig. 3 Low Level Output Voltage vs. Ambient Temperature**



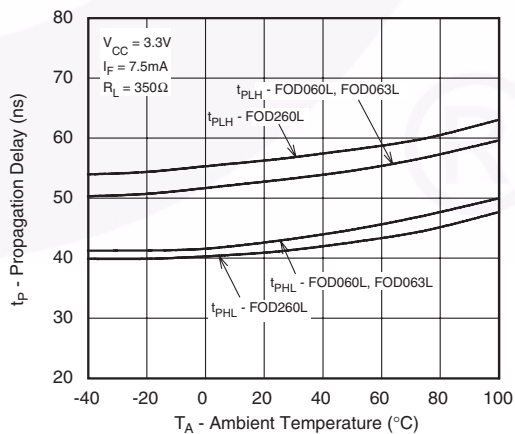
**Fig. 4 High Level Output Current vs. Ambient Temperature**



**Fig. 5 Low Level Output Current vs. Ambient Temperature**

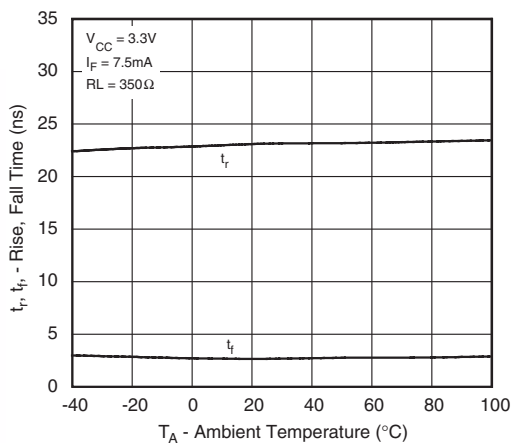


**Fig. 6 Propagation Delay vs. Ambient Temperature**

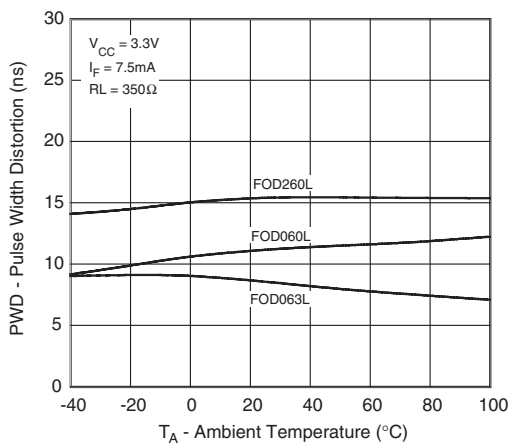


## Typical Performance Curves

**Fig. 7 Rise and Fall Times vs. Ambient Temperature**



**Fig. 8 Pulse Width Distortion vs. Ambient Temperature**



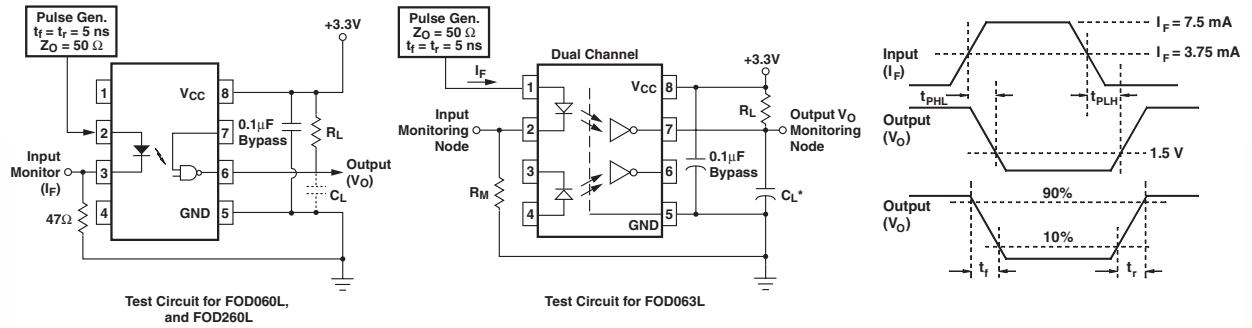


Fig. 9 Test Circuit and Waveforms for  $t_{PLH}$ ,  $t_{PHL}$ ,  $t_r$  and  $t_f$ .

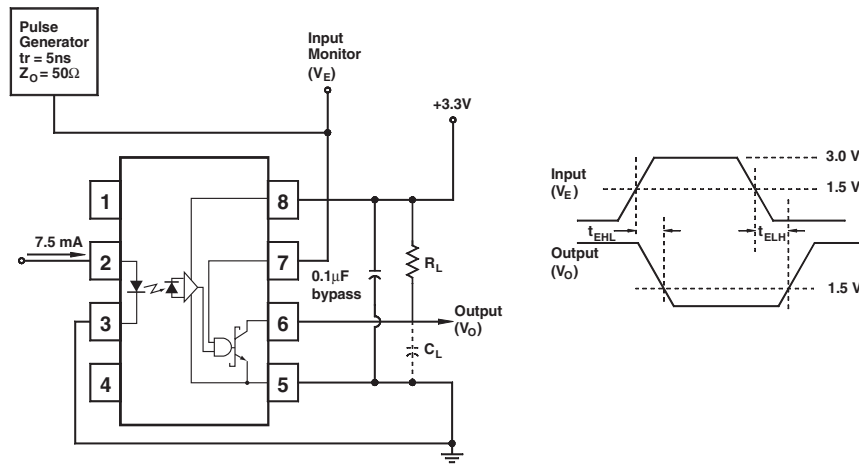


Fig. 10 Test Circuit  $t_{EHL}$  and  $t_{ELH}$ .

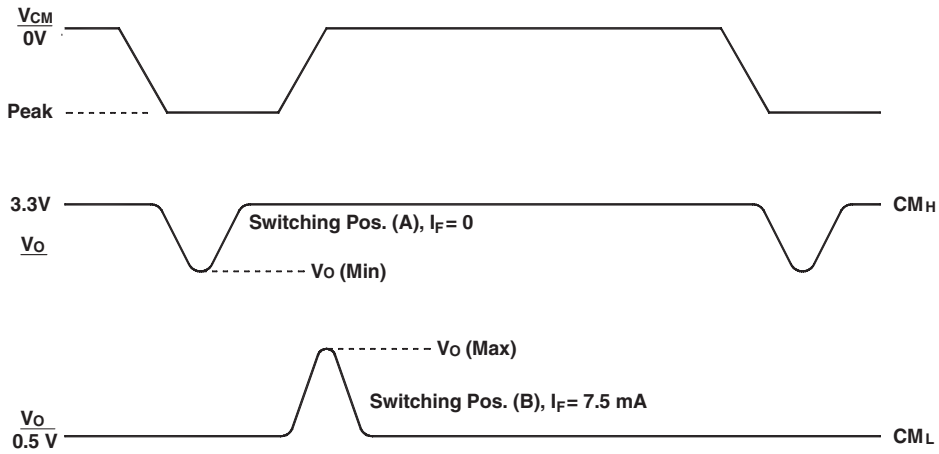
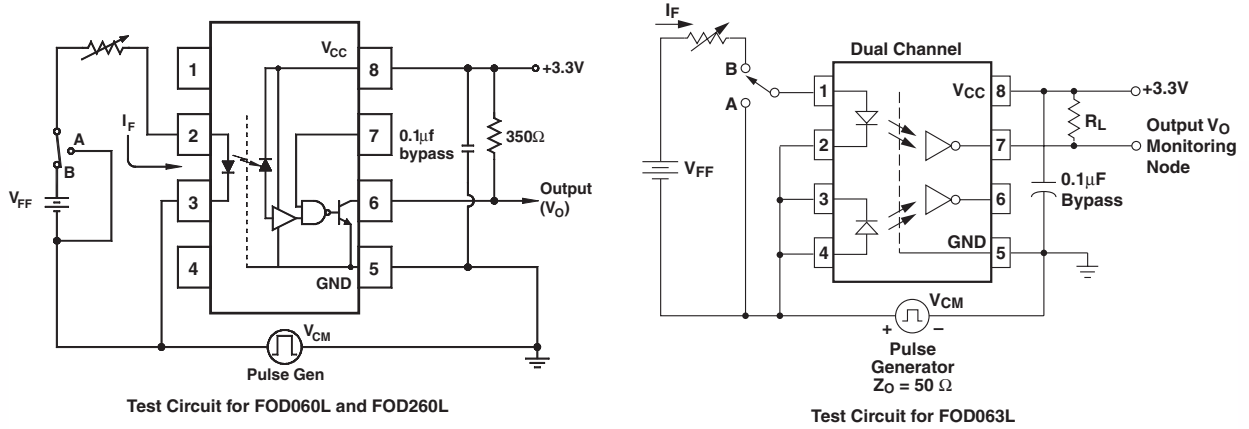
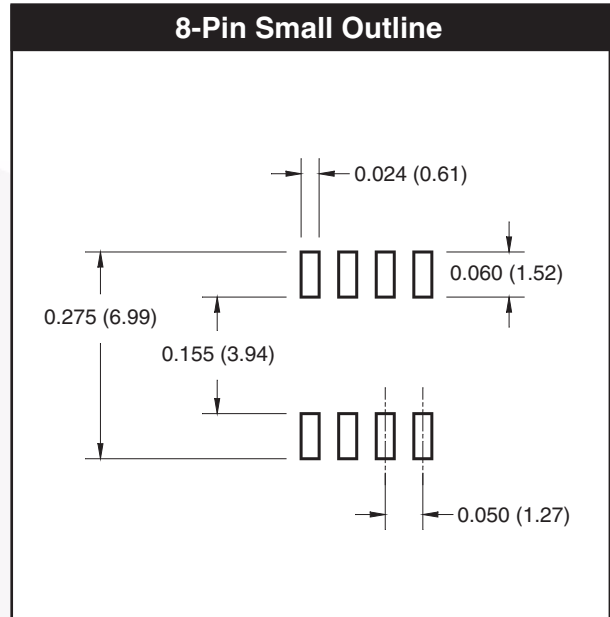
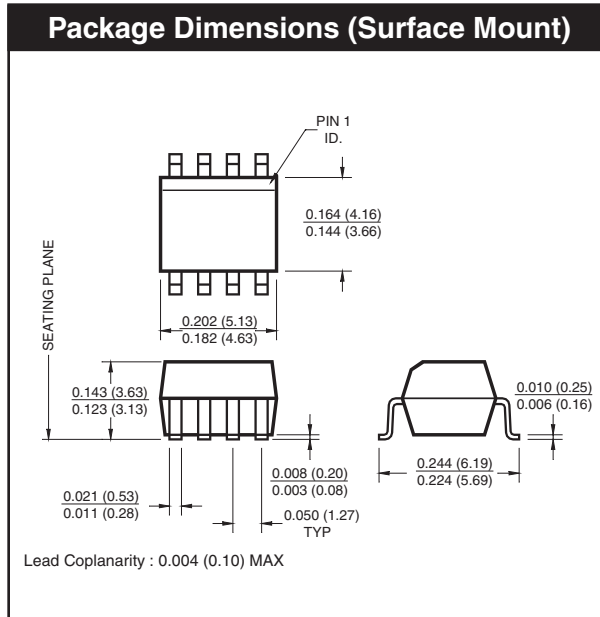


Fig. 11 Test Circuit Common Mode Transient Immunity

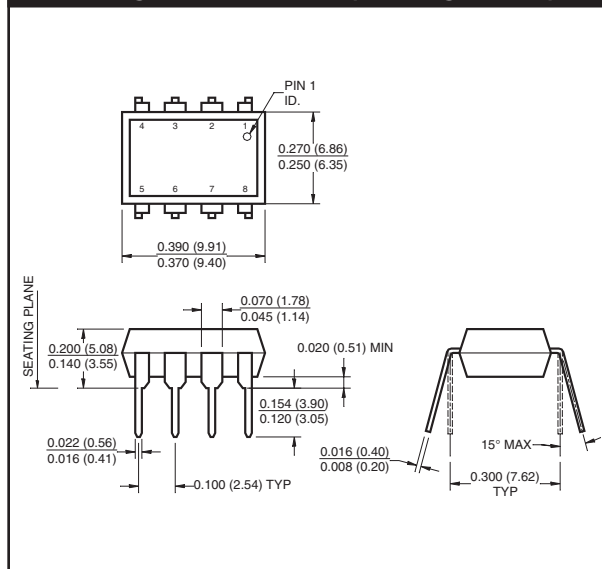


### 8-Pin SOIC

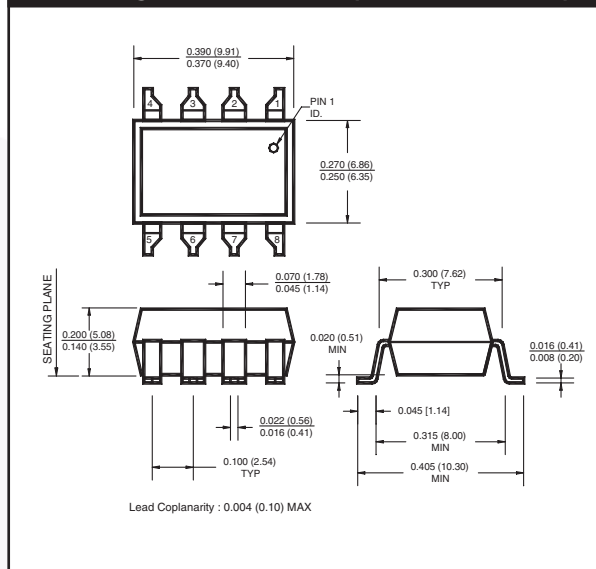


## 8-Pin DIP

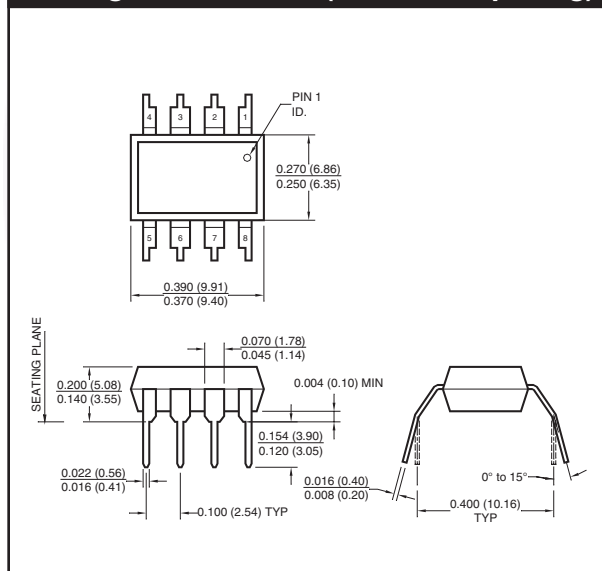
### Package Dimensions (Through Hole)



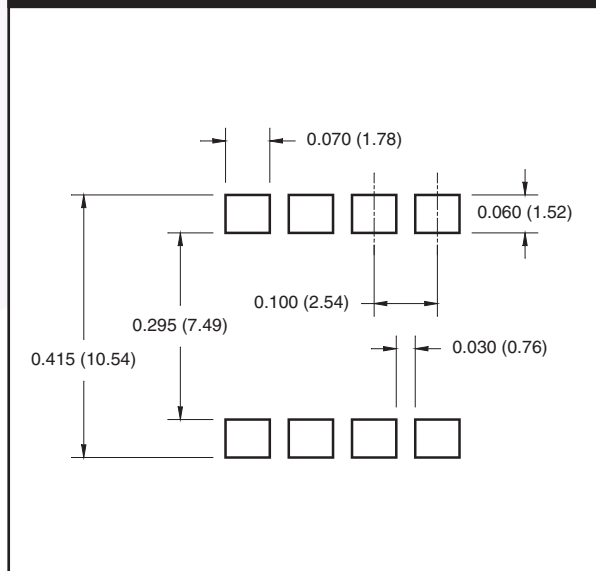
### Package Dimensions (Surface Mount)



### Package Dimensions (0.4" Lead Spacing)



### 8-Pin DIP



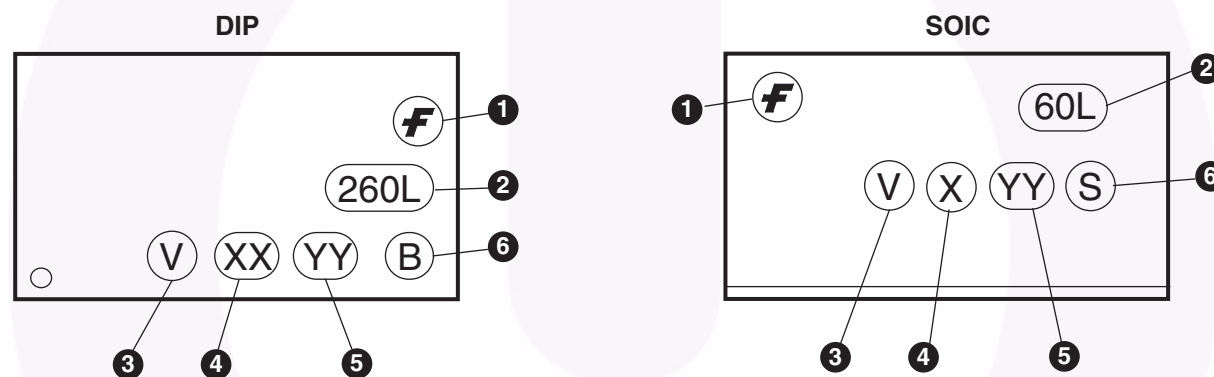
#### NOTE

All dimensions are in inches (millimeters)

## Ordering Information

Option	Order Entry Identifier	Description
No Suffix	FOD260L	Through Hole (DIP package only)
	FOD060L	Surface Mount Lead Form (SOIC-8 package only)
S	FOD260LS	Surface Mount Lead Bend (DIP package only)
SD	FOD260LSD	Surface Mount; Tape and reel (DIP package only)
SV	Pending Approval	Surface Mount; VDE0884 (DIP package only)
SDV	Pending Approval	Surface Mount; Tape and reel, VDE0884 (1000 units per reel) (DIP package only)
T	FOD260LT	0.4" Lead Spacing (DIP package only)
TV	Pending Approval	0.4" Lead Spacing, VDE0884 (DIP package only)
R1	FOD060LR1	Tape and Reel (500 units per reel) (SOIC-8 package only)
R1V	Pending Approval	VDE, Tape and Reel (500 units per reel) (SOIC-8 package only)
R2	FOD060LR2	Tape and Reel (2500 units per reel) (SOIC-8 package only)
R2V	Pending Approval	VDE, Tape and Reel (2500 units per reel) (SOIC-8 package only)
V	Pending Approval	VDE (SOIC-8 package only)

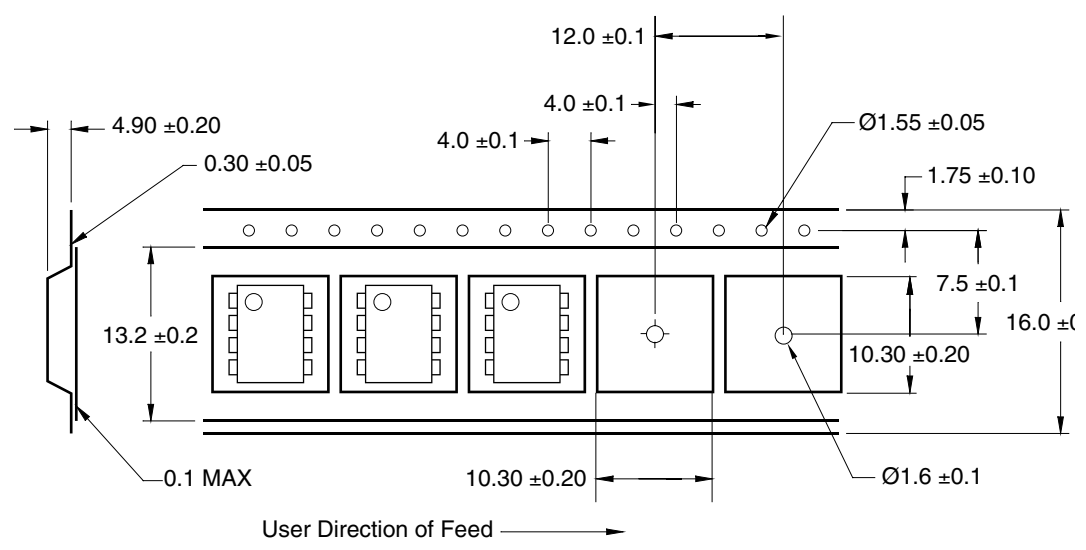
## Marking Information



Definitions	
1	Fairchild logo
2	Device number
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table)
4 (DIP)	Two digit year code, e.g., '03'
4 (SOIC)	One digit year code, e.g., '3'
5	Two digit work week ranging from '01' to '53'
6	Assembly package code

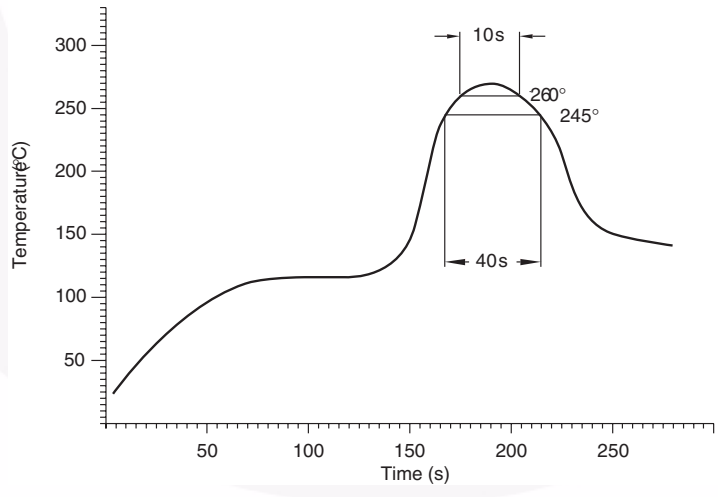
### 8-Pin DIP

#### Carrier Tape Specifications (FOD260L)



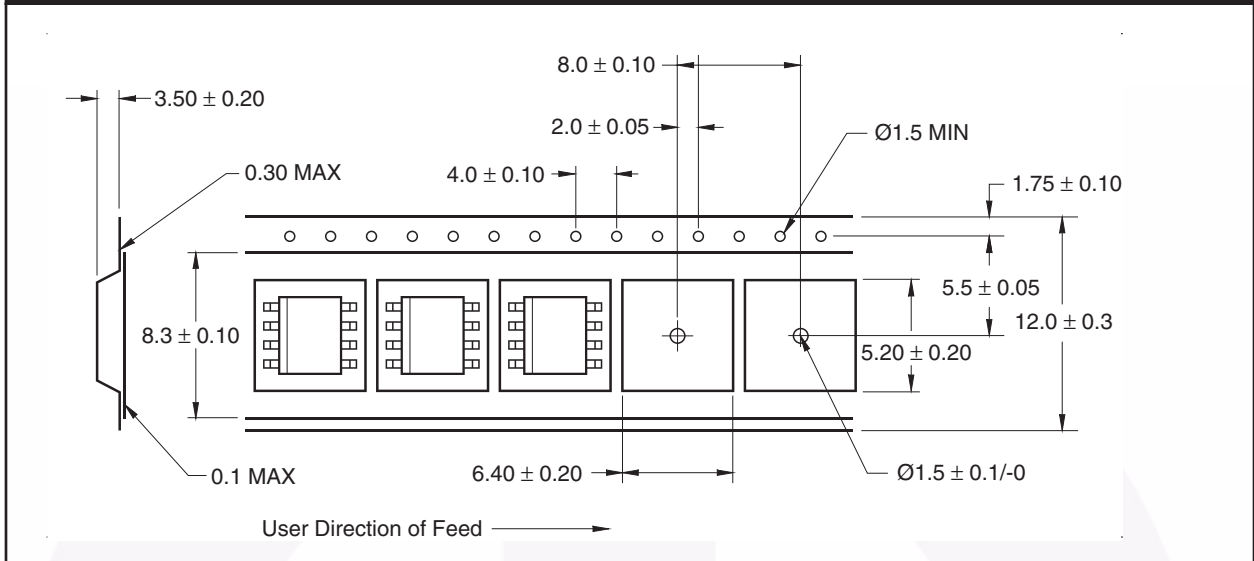
#### Reflow Profile (FOD260L)

- Peak reflow temperature 260° C (package surface temperature)
- Time of temperature higher than 245° C 40 seconds or less
- Number of reflows Three

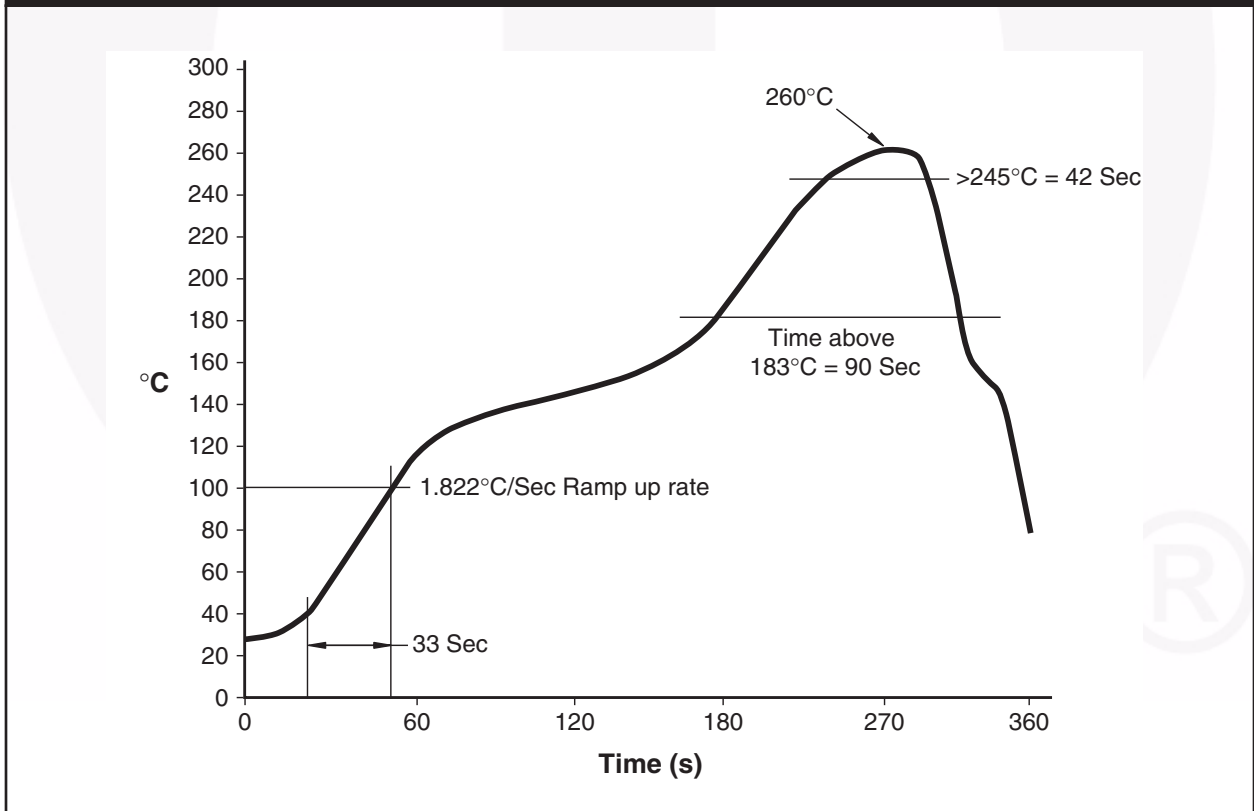


## 8-Pin SOIC

### Carrier Tape Specifications (FOD060L, FOD063L)



### Reflow Profile (FOD060L, FOD063L)





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| EfficientMax™            | MicroFET™              | SmartMax™                             |   |
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| ™                        | MicroPak2™             | SPM®                                  |   |
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| FACT Quiet Series™       | Motion-SPM™            | SuperSOT™-3                           |   |
| FACT®                    | OptoHIT™               | SuperSOT™-6                           |   |
| FAST®                    | OPTOLOGIC®             | SuperSOT™-8                           |   |
| FastCore™                | OPTOPLANAR®            | SupreMOS®                             |   |
| FETBench™                | ™                      | SyncFET™                              |   |
| FlashWriter®*            | PDP SPM™               | Sync-Lock™                            |   |
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- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

**ANTI-COUNTERFEITING POLICY**

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, [www.fairchildsemi.com](http://www.fairchildsemi.com), under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

**PRODUCT STATUS DEFINITIONS**

**Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

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